

IGBT3 Power Chip

Features:

- 1700V Trench & Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

• power modules



drives



Chip Type	V _{CE}	<i>I</i> _C	Die Size	Package
SIGC68T170R3E	1700V	50A	8.23 x 8.25 mm ²	sawn on foil

Mechanical Parameters

- Wiechanical Faranieters			
Raster size	8.23 x 8.25		
Emitter pad size (incl. gate pad)	4 x (2.94 x 2.97)	- mm²	
Gate pad size	1.18 x 1.09		
Area total	67.9		
Thickness	190	μm	
Wafer size	200	mm	
Max.possible chips per wafer	392		
Passivation frontside	Photoimide		
Pad metal	3200 nm AlSiCu		
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding		
Die bond	Electrically conductive glue or solder		
Wire bond	AI, <500μm		
Reject ink dot size	Ø 0.65mm ; max 1.2mm		
Recommended storage environment	Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C		



Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, T_{vj} =25 °C	V _{CE}	1700	V	
DC collector current, limited by $T_{\rm vj\;max}$	I _C	1)	Α	
Pulsed collector current, t_p limited by $T_{vj max}$	$I_{c,puls}$	150	А	
Gate emitter voltage	V _{GE}	±20	V	
Junction temperature range	T _{vj}	-40 +175	°C	
Operating junction temperature	T_{vj}	-40+150	°C	
Short circuit data ²⁾ $V_{GE} = 15V$, $V_{CC} = 1000V$, $T_{vj} = 150$ °C	t_{SC}	10	μs	
Reverse bias safe operating area ²⁾ (RBSOA)	$I_{C,max} = 100A, V_{CE,max} = 1700V$ $T_{vj} \le 150^{\circ}C$			

¹⁾ depending on thermal properties of assembly

Static Characteristic (tested on wafer), T_{vj} =25 °C

Parameter	Symbol	Conditions	Value			Unit
i didilietei		Conditions	min.	typ.	max.	
Collector-Emitter breakdown voltage	V _{(BR)CES}	$V_{\rm GE}$ =0V , $I_{\rm C}$ = 2.5 mA	1700			
Collector-Emitter saturation voltage	V _{CEsat}	$V_{\rm GE}$ =15V, $I_{\rm C}$ =50A	1.6	2	2.4	V
Gate-Emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =2mA , $V_{\rm GE}$ = $V_{\rm CE}$	5.2	5.8	6.4	
Zero gate voltage collector current	I _{CES}	V _{CE} =1700V , V _{GE} =0V			3	μA
Gate-Emitter leakage current	I _{GES}	V_{CE} =0V , V_{GE} =20V			600	nA
Integrated gate resistor	$r_{\rm G}$			9.5		Ω

Dynamic Characteristic (not subject to production test - verified by design / characterization), T_{vj} =25 °C

Parameter	Symbol	Conditions	Value			Unit
raiametei	Syllibol	Conditions	min.	typ.	max.	Ollit
Input capacitance	Cies	V _{CE} =25V,		4408		
Reverse transfer capacitance	C _{res}	V _{GE} =0V, <i>f</i> =1MHz		146		pF

²⁾ not subject to production test - verified by design/characterization



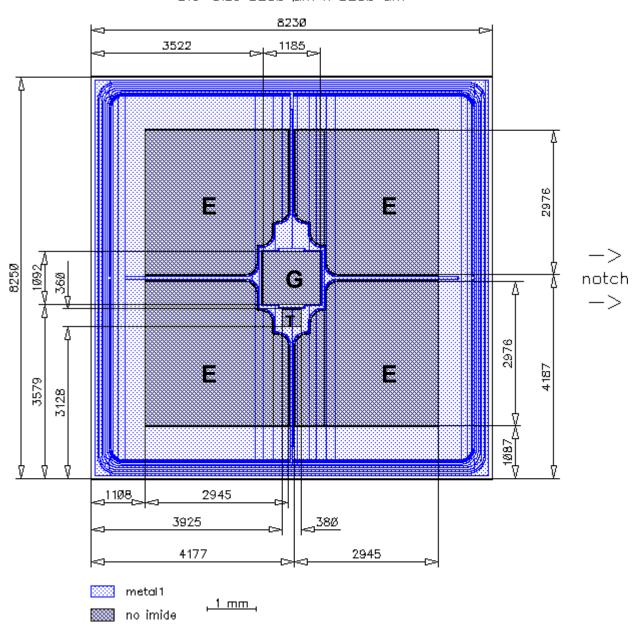
Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.



Chip Drawing





E = Emitter

 $\mathbf{G} = \mathsf{Gate}$

T = Test pad do not contact



Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date	
2.1	Change wafer size to 200 mm	14.04.2010	
2.2	Additional basic types L7761M, L7761T, L7761E	27.06.2014	

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